Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,693	BHOOSHAN ET AL.	
Examiner	Art Unit	
Phallaka Kik	2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	5,9,10	6/12/2006	PK	
Above	updated	1/11/2007	PK	
Above	updated	6/3/2007	PK	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCI		)
	DATE	EXMR
BRS (EAST)USPAT, USPGPUB Cls/Sub searched: 716/1-18 (see attached)	6/12/2006	PK
Above updated search (see attached)	1/11/2007	PK
Above updated search (see attached)	6/3/2007	PK
EPO, JPO, IBM TDB, Derwent (see attached)	6/12/2006	РК
IEE/IEEE Xplore (see attached)	6/12/2006	PK